Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/810,262	NAYLOR ET AL.
Examiner	Art Unit
Shin-Lin Chen	1632

	SEARCHED			
Class	Subclass	Date	Examiner	
Updated		12/11/2006	GN	
		1		
		-		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	•		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE EXMR	
Updated	12/11/2006	